Application/Control No. Applicant(s)/Patent Under Reexamination 10/004,885 ABURAKAWA ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 Khai M Nguyen 2687

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,802,173 A	09-1998	Hamilton-Piercy et al.	379/56.2
	В	US-6,807,374 B1	10-2004	Imajo et al.	398/115
	С	US-2003/0059039 A1	03-2003	Meyerson et al.	379/428.04
	D	US-5,982,854 A	11-1999	Ehreth, David	379/56.2
	Ε	US-6,497,599 B1	12-2002	Johnson et al.	455/447
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				·	·
	Q	.•				
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	x						

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Sates in MM-YYYY format are publication dates. Classifications may be US or foreign.